

<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10538498	ZHANG ET AL.
Examiner	Art Unit	
STUART W SNYDER	1648	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
Dialog: Magnetic or paramagnetic, microbead, cell, separate	5/29/2008	sws
EAST: Magnetic or paramagnetic, microbead, cell, separate; inventors	6/2/208	sws

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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